

Search Notes

Application/Control No.

10/614,129

Examiner

Sunray Chang

Applicant(s)/Patent under
Reexamination

HIRAI, NORIO

Art Unit

2121

SEARCHED

Class	Subclass	Date	Examiner
250	339.12	12/18/2005	SC
73	863.12	12/18/2005	SC
60	660	12/18/2005	SC
340	511	12/18/2005	SC
123	568	7/7/2006	SC
123	674	11/10/2006	SC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB)	12/18/2005	SC
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB)	7/7/2006	SC
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB)	11/10/2006	SC